

Substitute for form 1449A/B/PTO  <b>INFORMATION DISCLOSURE STATEMENT BY APPLICANT</b>  <i>(Use as many sheets as necessary)</i>				<b>Complete if Known</b>	
				Application Number	Not Yet Assigned
				Filing Date	Concurrently Herewith
				First Named Inventor	Gi-Hong Kim
				Art Unit	N/A
				Examiner Name	Not Yet Assigned
Sheet	1	of	2	Attorney Docket Number	8733.446.10-US

U.S. PATENT DOCUMENTS					
Examiner Initials*	Cite No. <sup>1</sup>	Document Number	Publication Date MM-DD-YYYY	Name of Patentee or Applicant of Cited Document	Pages, Columns, Lines, Where Relevant Passages or Relevant Figures Appear
		Number-Kind Code <sup>2</sup> (if known)			
HN		5,162,933 A	11-1992	Kakuda et al.	
		6,069,678 A	05-2000	Shakamoto et al.	
		6,133,977 A	10-2000	Lee et al.	
		6,111,627 A	08-2000	Kim et al.	
		6,452,656 B2	09-2002	Niwano et al.	

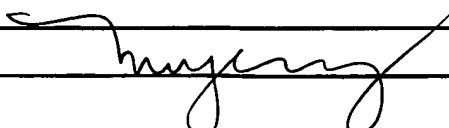
FOREIGN PATENT DOCUMENTS						
Examiner Initials*	Cite No. <sup>1</sup>	Foreign Patent Document	Publication Date MM-DD-YYYY	Name of Patentee or Applicant of Cited Document	Pages, Columns, Lines, Where Relevant Passages or Relevant Figures Appear	T <sup>6</sup>
		Country Code <sup>3</sup> -Number <sup>4</sup> -Kind Code <sup>5</sup> (if known)				
HN		JP411271810A	10-1999	Japan	Shibahara	

\*EXAMINER: Initial if reference considered, whether or not citation is in conformance with MPEP 609. Draw line through citation if not in conformance and not considered. Include copy of this form with next communication to applicant. <sup>1</sup> Applicant's unique citation designation number (optional). <sup>2</sup> See Kinds Codes of USPTO Patent Documents at [www.uspto.gov](http://www.uspto.gov) or MPEP 901.04. <sup>3</sup> Enter Office that issued the document, by the two-letter code (WIPO Standard ST.3). <sup>4</sup> For Japanese patent documents, the indication of the year of the reign of the Emperor must precede the serial number of the patent document. <sup>5</sup> Kind of document by the appropriate symbols as indicated on the document under WIPO Standard ST.16 if possible. <sup>6</sup> Applicant is to place a check mark here if English language Translation is attached.

NON PATENT LITERATURE DOCUMENTS			
Examiner Initials*	Cite No. <sup>1</sup>	Include name of the author (in CAPITAL LETTERS), title of the article (when appropriate), title of the item (book, magazine, journal, serial, symposium, catalog, etc.), date, page(s), volume-issue number(s), publisher, city and/or country where published.	T <sup>2</sup>

\*EXAMINER: Initial if reference considered, whether or not citation is in conformance with MPEP 609. Draw line through citation if not in conformance and not considered. Include copy of this form with next communication to applicant.

<sup>1</sup> Applicant's unique citation designation number (optional). <sup>2</sup> Applicant is to place a check mark here if English language Translation is attached.

Examiner Signature		Date Considered	8/5/05
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Form PTO 1449*  U.S. DEPARTMENT OF COMMERCE PATENT AND TRADEMARK OFFICE  <b>LIST OF REFERENCES CITED BY APPLICANT</b> <i>(Use Several Sheets if Necessary)</i>  Date: February 13, 2004				Attorney Docket No. 8733.446.10		Application No. Not Yet Assigned	
				Applicant Gi Hong KIM et al.			
Sheet 2 of 2				Filing Date February 13, 2004		Group TBA	
<b>U.S. PATENT DOCUMENTS</b>							
EXAMINER INITIAL*	DOCUMENT NUMBER	DATE	NAME	CLASS	SUBCLASS	FILING DATE IF APPROPRIATE	
HN	5,598,285	1/1997	Kondo et al.	349	39	September 20, 1993	
HN	5,745,207	4/1998	Asada et al.	349	141	November 27, 1996	
HN	5,905,556	5/1999	Suzuki et al.	349	141	July 11, 1997	
HN	5,946,060	8/1999	Nishiki et al.	349	48	June 3, 1997	
HN	5,946,066	8/1999	Lee et al.	349	141	June 25, 1998	
HN	6,266,116 B1	7/2001	Ohta et al.	349	141	September 26, 1996	
<b>FOREIGN PATENT DOCUMENTS</b>							
DOCUMENT NUMBER	DATE	COUNTRY	TRANSLATION				
			YES	NO			
JP 09-005764	1/1997	Japan	Abstract				
JP 09-073101	3/1997	Japan	Abstract				
JP 09-105908	4/1997	Japan	Abstract				
JP 09-101538	4/1997	Japan	Abstract				
<b>OTHER REFERENCES (Including Author, Title, Date, Pertinent Pages, Etc.)</b>							
	R. Kieler et al.; "In-Plane Switching of Nematic Liquid Crystals"; Japan Display '92; pages 547-550						
	M. Oh-e, et al.; "Principles and Characteristics of Electro-Optical Behaviour with In-Plane Switching Mode"; Asia Display '95; pages 577-580						
	M. Ohta et al.; "Development of Super-TFT-LCDs with In-Plane Switching Display Mode"; Asia Display '95; pages 707-710						
	S. Matsumoto et al.; "Display Characteristics of In-Plane Switching (IPS) LCDs and a Wide-Viewing-Angle 14.5-in. OPS TFT-LCD; Euro Display '96; pages 445-448						
	H. Wakemoto et al.; "An Advanced In-Plane Switching Mode TFT-LCD"; SID 97 Digest; pages 929-932						
	S.H. Lee et al.; "High-Transmittance, Wide-Viewing-Angle Nematic Liquid Crystal Display Controlled by Fringe-Field Switching; Asia Display '98; pages 371-374						
EXAMINER <u>myer</u> DATE CONSIDERED <u>8/5/05</u>							
*EXAMINER: Initial if reference is considered, whether or not citation is in conformance with MPEP 609; Draw line through citation if not in conformance and not considered. Include copy of this form with next communication to applicant.							
**English-language abstract provided.							